## Notice of References Cited

	Application/Control No. 09/965,224	Applicant(s)/Patent Under Reexamination QIAN, RICHARD		
	Examiner	Art Unit		
Į	Etienne P LeRoux	2161	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0268390	12-2004	Ibrahim Sezan et al.	725/035
	В	US-2002/0032772	03-2002	Olstad et al.	709/224
	С	US-5,638,531	06-1997	Crump et al.	711/123
	D	US-2003/0093790	05-2003	Logan et al.	725/38
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.